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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/774,417	02/10/2004	Yoshiki Nishibayashi	50212-559 1031	
McDermott, Wi	7590 02/20/200 ill & Emery	EXAMINER		
600 13th Street, N.W.			OLSEN, ALLAN W	
Washington, DC 20005-3096			ART UNIT	PAPER NUMBER
			1792	
			MAIL DATE	DELIVERY MODE
			02/20/2009	PAPER

Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

	Application	No.	Applicant(s)			
	10/774,417		NISHIBAYASHI ET AL.			
Office Action Summary	Examiner		Art Unit			
	Allan Olsen		1792			
The MAILING DATE of this commo Period for Reply	unication appears on the c	over sheet with the	correspondence address			
A SHORTENED STATUTORY PERIOD THE MAILING DATE OF THIS COMMU - Extensions of time may be available under the provisic after SIX (6) MONTHS from the mailing date of this co - If the period for reply specified above, the maximum - Failure to reply within the set or extended period for re Any reply received by the Office later than three month earned patent term adjustment. See 37 CFR 1.704(b)	NICATION. ons of 37 CFR 1.136(a). In no event mmunication. ((30) days, a reply within the statutor a statutory period will apply and will eply will, by statute, cause the applicate after the mailing date of this comn	t, however, may a reply be l ory minimum of thirty (30) da expire SIX (6) MONTHS froi ation to become ABANDON	timely filed ays will be considered timely. In the mailing date of this communication. IED (35 U.S.C. § 133).			
Status						
1) Responsive to communication(s) f	iled on <i>24 November 200</i>)8.				
2a)⊠ This action is FINAL .	· · · · · · · · · · · · · · · · · · ·					
<u>'</u>						
closed in accordance with the prac	•	-				
Disposition of Claims						
4) ☐ Claims <u>1,3,4,12,14-16 and 19-23</u> at 4a) Of the above claims <u>15</u> is with constant of the above claims <u>15</u> is with constant of the above claims <u>1,3,4,12,14,16 and 19-23</u> at 7) ☐ Claim(s) is/are objected to. 8) ☐ Claim <u>15</u> is subject to restriction at	drawn from consideration. are rejected.					
Application Papers						
9) ☐ The specification is objected to by 10) ☑ The drawing(s) filed on 02 May 20 Applicant may not request that any ob Replacement drawing sheet(s) includi 11) ☐ The oath or declaration is objected	07 is/are: a)⊠ accepted bjection to the drawing(s) be ng the correction is required	held in abeyance. So I if the drawing(s) is o	ee 37 CFR 1.85(a). objected to. See 37 CFR 1.121(d).			
Priority under 35 U.S.C. § 119						
12) Acknowledgment is made of a claim a) All b) Some * c) None of: 1. Certified copies of the priori 2. Certified copies of the priori 3. Copies of the certified copies application from the Internat * See the attached detailed Office act	ty documents have been ty documents have been es of the priority documen tional Bureau (PCT Rule	received. received in Applica ts have been receiv 17.2(a)).	ation No. <u>09/995,854</u> . ved in this National Stage			
Attachment(s)						
Attachment(s) 1) \(\sum \) Notice of References Cited (PTO-892)	4	l)	ry (PTO-413)			
 Notice of Treferences Cited (1 10-652) Notice of Draftsperson's Patent Drawing Review Information Disclosure Statement(s) (PTO-1449 Paper No(s)/Mail Date 	or PTO/SB/08) 5	Paper No(s)/Mail I				

DETAILED ACTION

Election/Restrictions

As noted in the Office action of June 23, 2008, claim 15 is withdrawn from consideration as claim 15 is directed to an invention that is independent or distinct from the invention originally claimed.

Response to Arguments

Applicant's arguments filed November 24, 2008 have been fully considered but they are not persuasive.

Applicant argues that the applied references fail to teach monitoring the ratio between the intensity of atomic oxygen and molecular oxygen emissions.

The examiner notes that the "wherein" clause of claim 1 does positively recite method steps and the condition set forth in the wherein clause are considered to be inherent in a method that uses the same etching conditions. As noted in the telephone interview of February 12, 2009, the rejection could be overcome if applicant were to amend the claims to positively recite method steps that pertain to the elements of the wherein clause.

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

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Claims 1, 3, 4, 12, 14, 16 and 19-23 are rejected under 35 U.S.C. 103(a) as being unpatentable over the paper by Shiomi, "High-Rate Reactive Ion Etching of Diamond and Fabrication of Porous Diamond for Field-Emission Cathode", in New Diamond, Vol. 13, No 4. pp 28-29, in view of US Patent 6,261,726 issued to Brooks et al. and further in view of US Patent 6,013,191 issued to Nasser-Faili et al. (hereinafter, Shiomi, Brooks and Nasser-Faili, respectively).

Shiomi teaches the reactive ion etching of a masked diamond surface. Shiomi teaches the mask comprises aluminum (page 2, line 17 of translation). Shiomi teaches that diamond is etched by a plasma of 100% O₂. Shiomi teaches that the plasma may alternatively comprise NO₂ or N₂. Shiomi teaches that the angle of the sidewall can be controlled by adding CF₄ to the etchant. Shiomi teaches that vertical sidewalls can be obtained by adding a very small amount of CF₄. Shiomi teaches using a CF₄ concentration as low as 0.125% (page 5, line 2).

With respect to independent claims 1 and 12, Shiomi does not teach supplying less than 1.0 W/cm² of power to the RIE process. With respect to independent claims 17 and 18, Shiomi does not teach supplying at least 0.45 W/cm² of power to the RIE process. Shiomi does not teach using a both O₂ and N₂ in the plasma gas.

Brooks teaches etching diamond with a mixture of O_2 and N_2 (see col 6, line 63).

Nasser-Faili teaches etching diamond within various types of plasma chambers and under a variety of process conditions. Nasser-Faili teaches using a power density of "about 1 W/cm²" which encompasses the claimed "less than 1.0 W/cm²" and the claimed "at least 0.45 W/cm²".

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It would have been obvious to one skilled in the art to etch diamond with plasma comprising O_2 and N_2 and a fluorine-containing compound because Shiomi teaches using either O_2 or N_2 and "[i]t is prima facie obvious to combine two compositions each of which is taught by the prior art to be useful for the same purpose, in order to form a third composition which is to be used for the very same purpose." Furthermore, because Shiomi teaches etching diamond with an O_2 plasma while Brooks teaches etching diamond with an O_2/N_2 plasma, a person having ordinary skill in the art would recognize an O_2 plasma and an O_2/N_2 plasma as being are functionally equivalent with respect to the etching of diamond. Furthermore, it would have been obvious to use N_2 in an amount between, the claimed 2.5 % and 40 % because Shiomi teaches that 100% O_2 etches diamond, therefore, one skilled in the art would view N_2 as an additive and would not be expect to use N_2 as the major component over the O_2 etchant. As such, it would be obvious to use less N_2 than O_2 (i.e., between ~1% and 50%).

It would have been obvious to one skilled in the art to add fluorine to the O_2/N_2 mixture of Brooks because Shiomi teaches that the addition of fluorine allows one to gain control over the etching profile. Additionally, in view of Nasser-Faili's teaching, the skilled artisan would have reasonable expectation of success because Nasser-Faili demonstrates the etching of diamond with plasma comprising oxygen, nitrogen and a low fluorine content.

¹ In re Kerkhoven 205 USPQ 1069 (CCPA 1980). Cites In re Susi 169 USPQ 423, 426 (CCPA 1971); In re Crockett 126 USPQ 186, 188 (CCPA 1960). See also Ex parte Quadranti 25 USPQ 2d 1071 (BPAI 1992).

It would have been obvious to one skilled in the art to apply power with a power density of least 0.45 W/cm² because Nasser-Faili teaches that by supplying 1.5 W/cm² of power, one can obtain vertical structures similar to those obtained taught by Shiomi.

Conclusion

THIS ACTION IS MADE FINAL. Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the mailing date of this final action.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Allan Olsen whose telephone number is 571-272-1441. The examiner can normally be reached on M, W and F: 1-5.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Parviz Hassanzadeh can be reached on 571-272-1435. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

/Allan Olsen/ Primary Examiner, Art Unit 1792